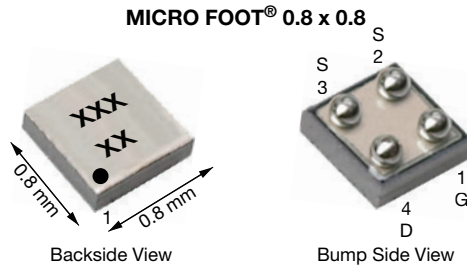


N-Channel 30 V (D-S) MOSFET



Marking code: xx = AR
xxx = Date/lot traceability code

PRODUCT SUMMARY	
V_{DS} (V)	30
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10$ V	0.128
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5$ V	0.131
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 3.7$ V	0.134
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 2.5$ V	0.143
Q_g typ. (nC)	2.4
I_D (A) ^a	2.2
Configuration	Single

ORDERING INFORMATION	
Package	MICRO FOOT® 0.8 x 0.8
Lead (Pb)-free and halogen-free	Si8818EDB-T2-E1

ABSOLUTE MAXIMUM RATINGS ($T_A = 25$ °C, unless otherwise noted)				
Parameter	Symbol	Limit	Unit	
Drain-source voltage	V_{DS}	30	V	
Gate-source voltage	V_{GS}	± 12		
Continuous drain current ($T_J = 150$ °C)	I_D	$T_A = 25$ °C	2.2 ^a	A
		$T_A = 70$ °C	1.7 ^a	
		$T_A = 25$ °C	1.6 ^b	
		$T_A = 70$ °C	1.2 ^b	
Pulsed drain current ($t = 300$ μ s)	I_{DM}	8		
Continuous source-drain diode current	I_S	$T_A = 25$ °C	0.7 ^a	
		$T_A = 25$ °C	0.4 ^b	
Maximum power dissipation	P_D	$T_A = 25$ °C	0.9 ^a	W
		$T_A = 70$ °C	0.6 ^a	
		$T_A = 25$ °C	0.5 ^b	
		$T_A = 70$ °C	0.3 ^b	
Operating junction and storage temperature range	T_J, T_{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) ^c		260		

THERMAL RESISTANCE RATINGS				
Parameter	Symbol	Typical	Maximum	Unit
Maximum junction-to-ambient ^{a, d}	R_{thJA}	105	135	°C/W
Maximum junction-to-ambient ^{b, e}		200	260	

Notes

- Surface mounted on 1" x 1" FR4 board with full copper, $t = 5$ s
- Surface mounted on 1" x 1" FR4 board with minimum copper, $t = 5$ s
- Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering
- Maximum under steady state conditions is 185 °C/W
- Maximum under steady state conditions is 330 °C/W

FEATURES

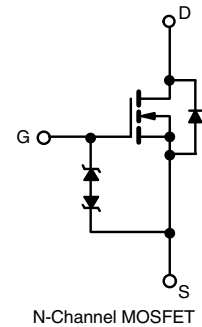
- TrenchFET® power MOSFET
- Ultra small 0.8 mm x 0.8 mm outline
- Ultra thin 0.39 mm max. height
- Typical ESD protection 1700 V (HBM)
- Material categorization:
for definitions of compliance please see www.vishay.com/doc?99912



RoHS
COMPLIANT
HALOGEN
FREE

APPLICATIONS

- Load switch
- OVP switch
- High speed switching
- DC/DC converters
- For smart phones, tablet PCs, and mobile computing





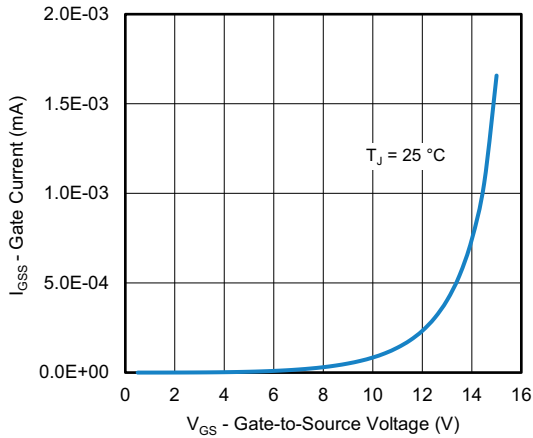
SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted)						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	30	-	-	V
V_{DS} temperature coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\text{ }\mu\text{A}$	-	30	-	mV/°C
$V_{GS(th)}$ temperature coefficient	$\Delta V_{GS(th)}/T_J$		-	-3.0	-	
Gate-source threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	0.6	-	1.0	V
Gate-source leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 4.5\text{ V}$	-	-	± 0.1	μA
		$V_{DS} = 0\text{ V}, V_{GS} = \pm 12\text{ V}$	-	-	± 1	
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$	-	-	1	
		$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$	-	-	10	
On-state drain current ^a	$I_{D(on)}$	$V_{DS} \geq 5\text{ V}, V_{GS} = 10\text{ V}$	10	-	-	A
Drain-source on-state resistance ^a	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 1\text{ A}$	-	0.095	0.128	Ω
		$V_{GS} = 4.5\text{ V}, I_D = 1\text{ A}$	-	0.100	0.131	
		$V_{GS} = 3.7\text{ V}, I_D = 1\text{ A}$	-	0.105	0.134	
		$V_{GS} = 2.5\text{ V}, I_D = 0.5\text{ A}$	-	0.120	0.143	
Forward transconductance ^a	g_{fs}	$V_{DS} = 10\text{ V}, I_D = 2\text{ A}$	-	10	-	S
Dynamic ^b						
Input capacitance	C_{iss}	$V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	-	206	-	pF
Output capacitance	C_{oss}		-	40	-	
Reverse transfer capacitance	C_{rss}		-	20	-	
Total gate charge	Q_g	$V_{DS} = 15\text{ V}, V_{GS} = 10\text{ V}, I_D = 1\text{ A}$	-	4.6	8	nC
			$V_{DS} = 15\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 1\text{ A}$	-	2.4	
Q_{gs}	-	0.6		-		
Q_{gd}	-	0.4		-		
Gate resistance	R_g	$f = 1\text{ MHz}$	-	4	-	Ω
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 15\text{ V}, R_L = 15\text{ }\Omega$ $I_D \cong 1\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\text{ }\Omega$	-	15	30	ns
Rise time	t_r		-	20	40	
Turn-off delay time	$t_{d(off)}$		-	20	40	
Fall time	t_f		-	10	20	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 15\text{ V}, R_L = 15\text{ }\Omega$ $I_D \cong 1\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\text{ }\Omega$	-	5	10	
Rise time	t_r		-	10	20	
Turn-off delay time	$t_{d(off)}$		-	15	30	
Fall time	t_f		-	5	10	
Drain-Source Body Diode Characteristics						
Continuous source-drain diode current	I_S	$T_C = 25\text{ }^\circ\text{C}$	-	-	0.7	A
Pulse diode forward current	I_{SM}		-	-	8	
Body diode voltage	V_{SD}	$I_S = 50\text{ mA}, V_{GS} = 0\text{ V}$	-	0.56	1.0	V
Body diode reverse recovery time	t_{rr}	$I_F = 1\text{ A}, di/dt = 100\text{ A}/\mu\text{s},$ $T_J = 25\text{ }^\circ\text{C}$	-	16	30	ns
Body diode reverse recovery charge	Q_{rr}		-	6	12	nC
Reverse recovery fall time	t_a		-	13.5	-	ns
Reverse recovery rise time	t_b		-	2.5	-	

Note

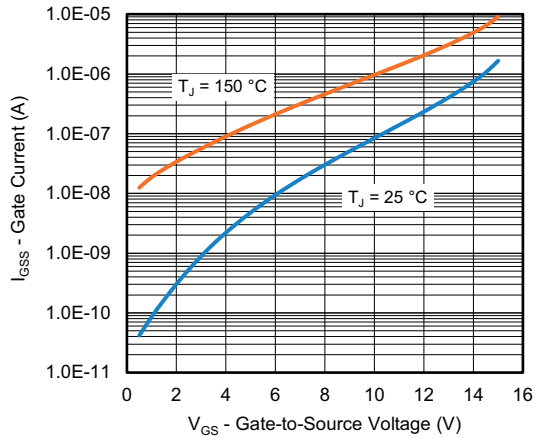
- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$
- b. Guaranteed by design, not subject to production testing
- c. Pulse diode forward transient current: pulse width at 100 ms, duty cycle $\leq 2\%$. I_{SM} max. = 1.5 A

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

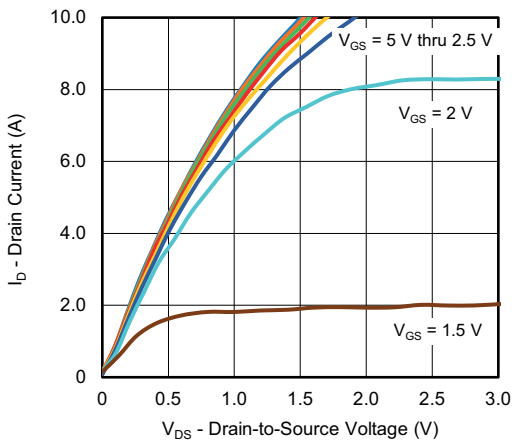
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



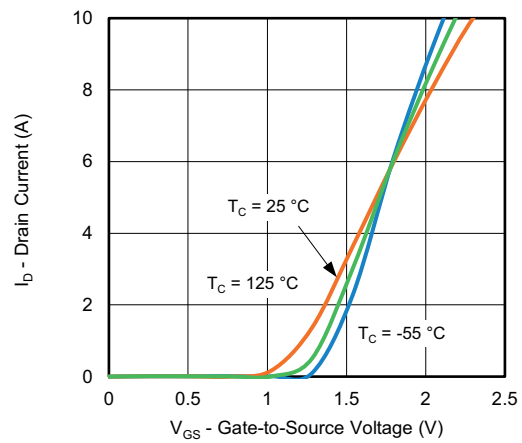
Gate Current vs. Gate-Source Voltage



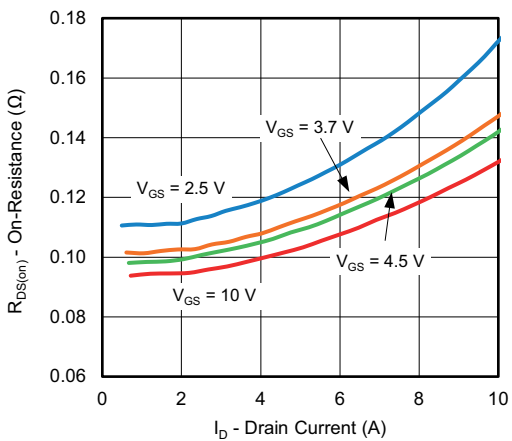
Gate Current vs. Gate-Source Voltage



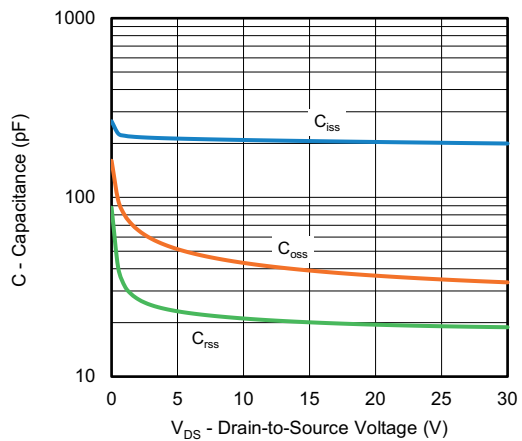
Output Characteristics



Transfer Characteristics



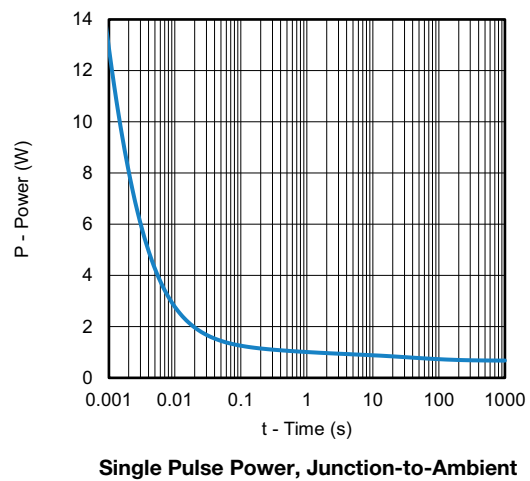
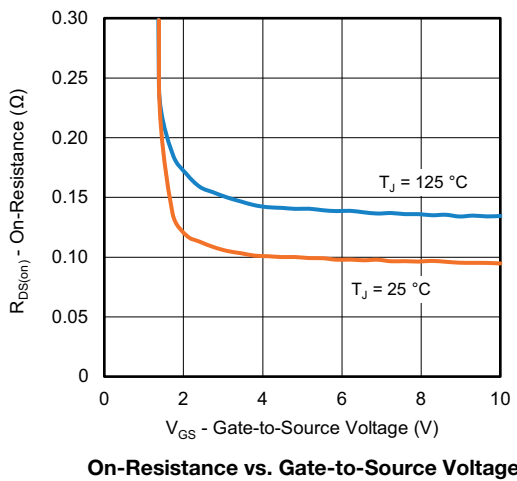
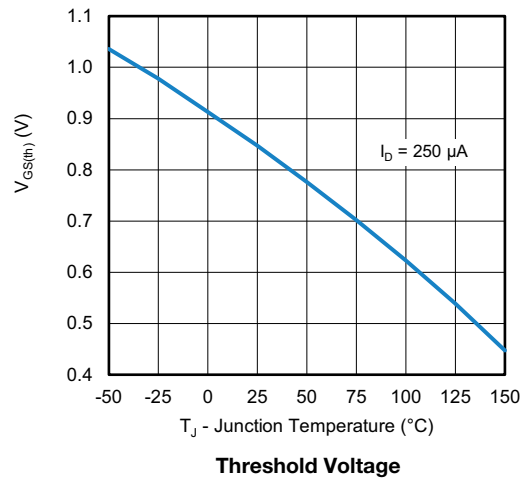
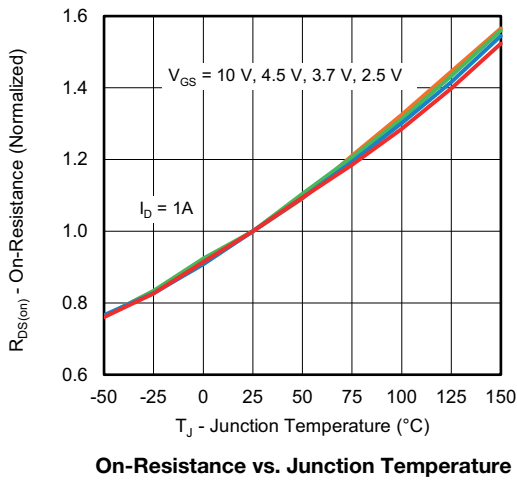
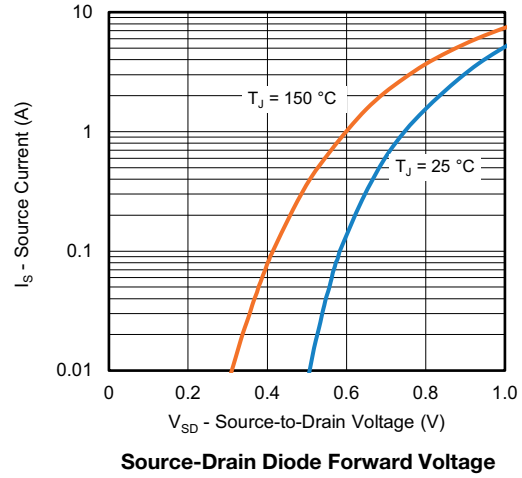
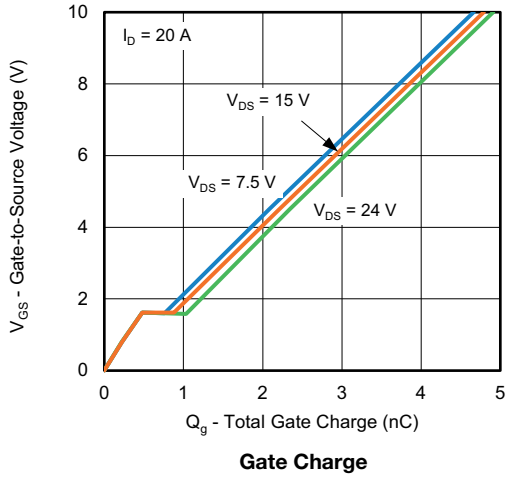
On-Resistance vs. Drain Current



Capacitance vs. Drain-to-Source Voltage

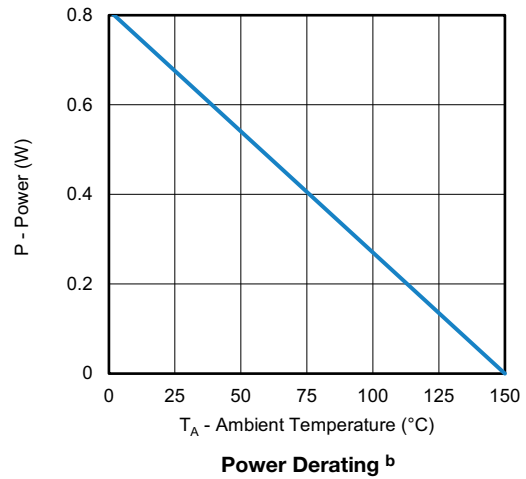
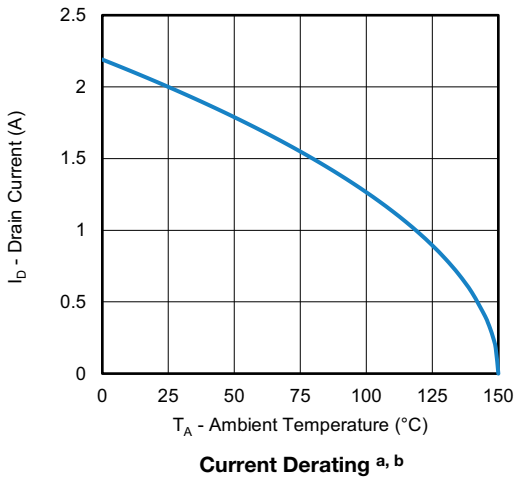
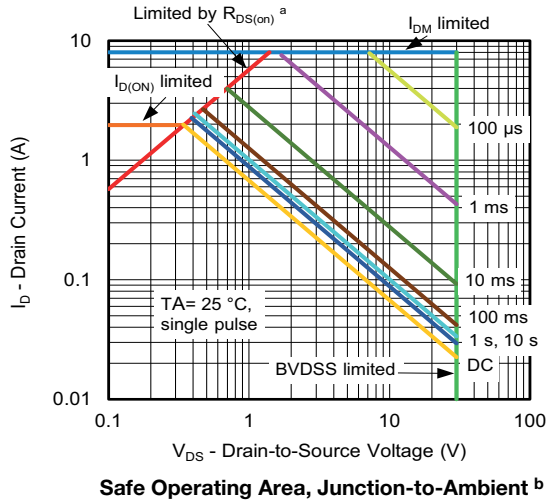


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

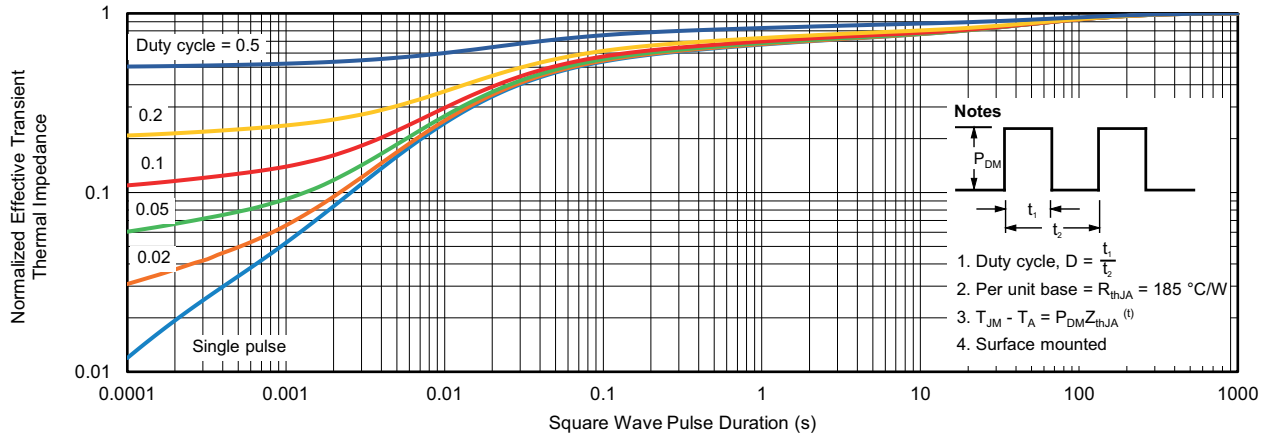


Notes

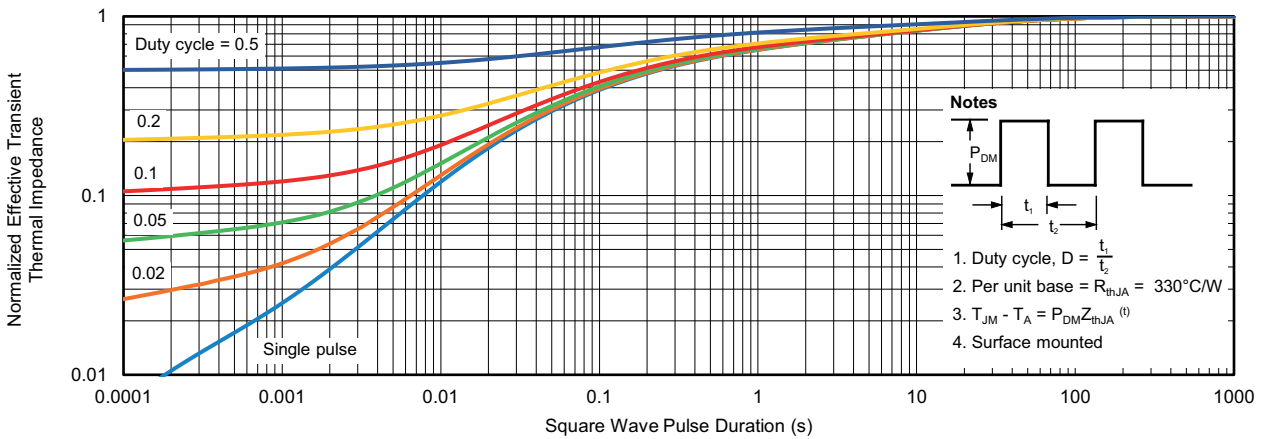
- a. The power dissipation P_D is based on $T_J \text{ max.} = 150^\circ\text{C}$, using junction-to-ambient thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit
- b. When mounted on 1" x 1" FR4 with full copper



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient (On 1" x 1" FR4 Board with Maximum Copper)



Normalized Thermal Transient Impedance, Junction-to-Ambient (On 1" x 1" FR4 Board with Minimum Copper)

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